

N-channel dual-gate MOS-FET**BF908WR****FEATURES**

- High forward transfer admittance
- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier up to 1 GHz.

APPLICATIONS

- VHF and UHF applications with 12 V supply voltage, such as television tuners and professional communications equipment.

DESCRIPTION

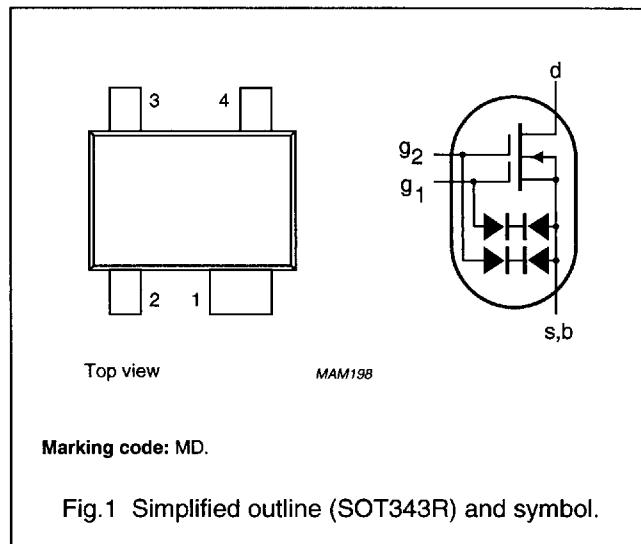
Depletion type field effect transistor in a plastic microminiature SOT343R package. The transistor is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.

PINNING

PIN	SYMBOL	DESCRIPTION
1	s, b	source
2	d	drain
3	g ₂	gate 2
4	g ₁	gate 1

**QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		—	—	12	V
I _D	drain current		—	—	40	mA
P _{tot}	total power dissipation		—	—	300	mW
T _j	operating junction temperature		—	—	150	°C
y _{fs}	forward transfer admittance		36	43	50	mS
C _{ig1-s}	input capacitance at gate 1		2.4	3.1	4	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz	20	30	45	fF
F	noise figure	f = 800 MHz	—	1.5	2.5	dB

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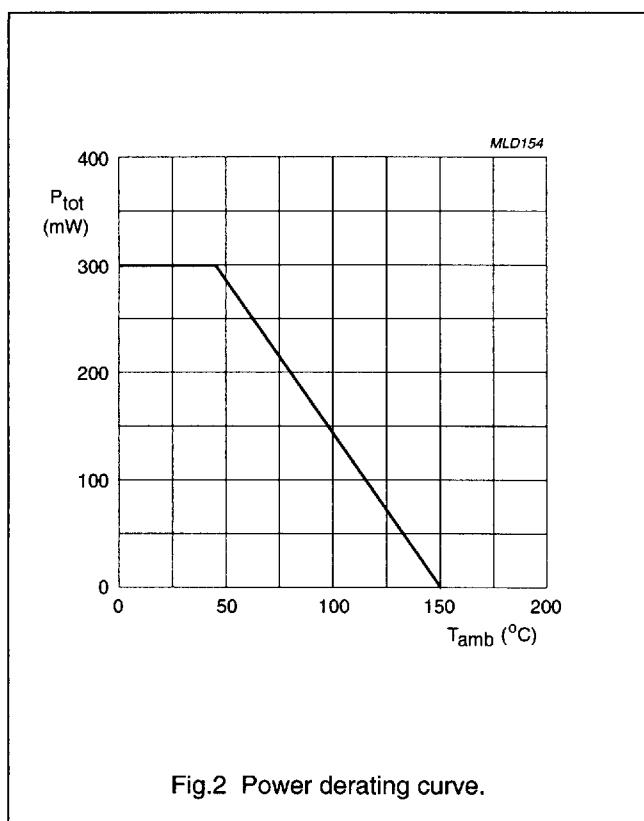
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS}	drain-source voltage		—	12	V
I_D	drain current		—	40	mA
I_{G1}	gate 1 current		—	± 10	mA
I_{G2}	gate 2 current		—	± 10	mA
P_{tot}	total power dissipation	up to $T_{amb} = 45^\circ\text{C}$; see Fig.2; note 1	—	300	mW
T_{sig}	storage temperature		-65	+150	$^\circ\text{C}$
T_j	operating junction temperature		—	+150	$^\circ\text{C}$

Note

1. Device mounted on a printed-circuit board.



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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j-a}$	thermal resistance from junction to ambient	note 1	350	K/W
$R_{th\ j-s}$	thermal resistance from junction to soldering point	$T_s = 87^\circ C$; note 2	210	K/W

Notes

1. Device mounted on a printed-circuit board.
2. T_s is the temperature at the soldering point of the source lead.

STATIC CHARACTERISTICS

 $T_j = 25^\circ C$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)G1-ss}$	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0$; $I_{G1-S} = 10 \text{ mA}$	8	—	20	V
$V_{(BR)G2-ss}$	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0$; $I_{G2-S} = 10 \text{ mA}$	8	—	20	V
$V_{(P)G1-S}$	gate 1-source cut-off voltage	$V_{G2-S} = 4 \text{ V}$; $V_{DS} = 8 \text{ V}$; $I_D = 20 \mu\text{A}$	—	—	-2	V
$V_{(P)G2-S}$	gate 2-source cut-off voltage	$V_{G1-S} = 4 \text{ V}$; $V_{DS} = 8 \text{ V}$; $I_D = 20 \mu\text{A}$	—	—	-1.5	V
I_{DSS}	drain-source current	$V_{G2-S} = 4 \text{ V}$; $V_{DS} = 8 \text{ V}$; $V_{G1-S} = 0$	3	15	27	mA
I_{G1-ss}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0$; $V_{G1-S} = 5 \text{ V}$	—	—	50	nA
I_{G2-ss}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0$; $V_{G2-S} = 5 \text{ V}$	—	—	50	nA

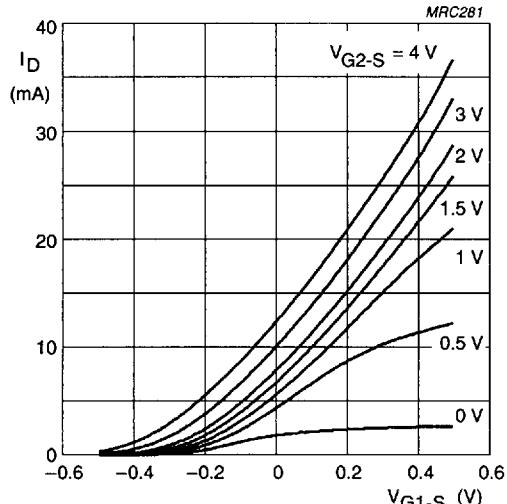
DYNAMIC CHARACTERISTICS

Common source; $T_{amb} = 25^\circ C$; $V_{DS} = 8 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D = 15 \text{ mA}$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$ y_{fs} $	forward transfer admittance	pulsed; $T_j = 25^\circ C$	36	43	50	mS
C_{ig1-s}	input capacitance at gate 1	$f = 1 \text{ MHz}$	2.4	3.1	4	pF
C_{ig2-s}	input capacitance at gate 2	$f = 1 \text{ MHz}$	1.2	1.8	2.5	pF
C_{os}	drain-source capacitance	$f = 1 \text{ MHz}$	1.2	1.7	2.2	pF
C_{rs}	reverse transfer capacitance	$f = 1 \text{ MHz}$	20	30	45	fF
F	noise figure	$f = 200 \text{ MHz}$; $G_S = 2 \text{ mS}$; $B_S = B_{Sopt}$	—	0.6	1.2	dB
		$f = 800 \text{ MHz}$; $G_S = G_{Sopt}$; $B_S = B_{Sopt}$	—	1.5	2.5	dB

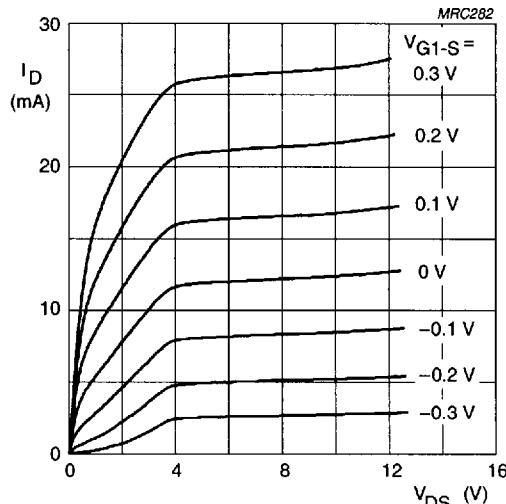
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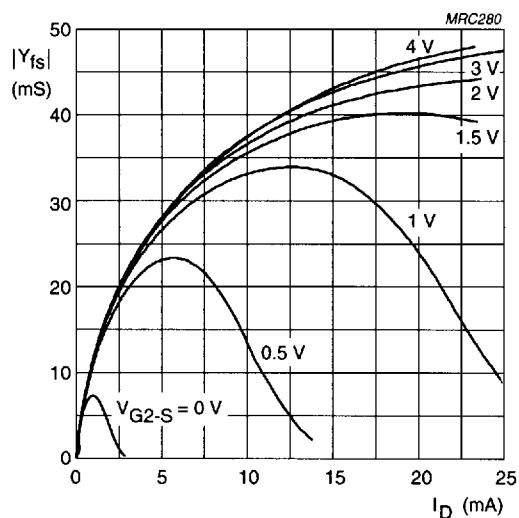
$V_{DS} = 8$ V.
 $T_j = 25$ °C.

Fig.3 Transfer characteristics; typical values.



$V_{G2-S} = 4$ V.
 $T_j = 25$ °C.

Fig.4 Output characteristics; typical values.



$V_{DS} = 8$ V.
 $T_j = 25$ °C.

Fig.5 Forward transfer admittance as a function of drain current; typical values.

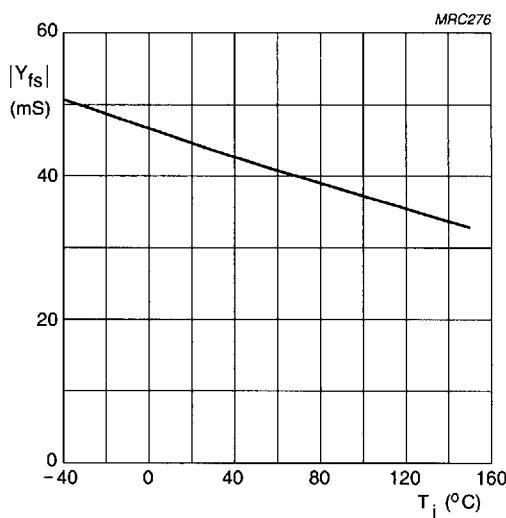
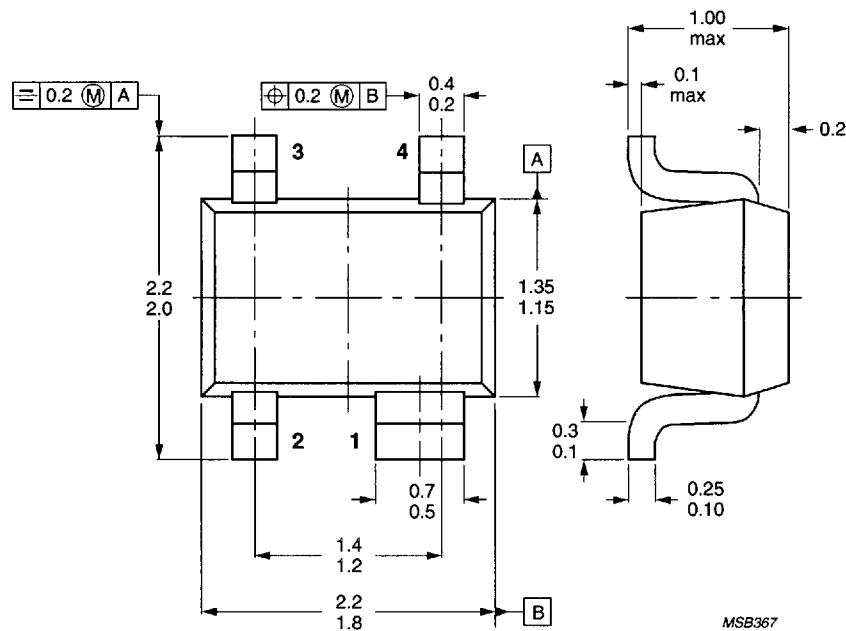


Fig.6 Forward transfer admittance as a function of junction temperature; typical values.

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PACKAGE OUTLINE



Dimensions in mm.

Fig.7 SOT343R.